XA-10097
PATENT APPLICATION #1

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of:

Michitaro KANAMITSU et al.

Intl. Appln. No.: PCT/JP02/01846

Intl. Filing Date: 28 February 2002

For: NONVOLATILE SEMICONDUCTOR STORAGE UNIT

* * *

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450
Attn: Mail Stop PCT, DO/EO/US

Sir:

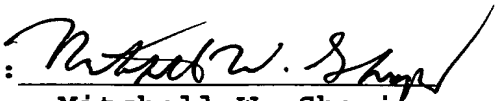
Pursuant to 37 C.F.R. § 1.56, and without any assertion as to materiality or prior art effect, the documents listed on the attached Form PTO-1449 are hereby cited.

Documents AH-AJ on the attached List were cited in the International Search Report (copy attached).

Documents AO-AQ (copies herewith) are cited in the

specification, on page 2, and their relevance is indicated therein.

Respectfully submitted,

By: 
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July 15, 2004

FORM PTO-1449 LIST OF DOCUMENTS CITED BY APPLICANT	Atty. Docket No. XA-10097	Appln. No. 10/501391
	Applicant Michitaro KANAMITSU et al.	
	Filing Date Herewith	Group

U.S. PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Name	Class	Sub-class	Filing Date
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						

FOREIGN PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Country	Class	Sub-class	Translation
	AH	11-250681	9/17/99	Japan			No
	AI	7-307098	11/21/95	Japan			No
	AJ	10-188576	7/21/98	Japan			No
	AK						
	AL						
	AM						
	AN						

OTHER (including author, title, date, pertinent pages, etc.)

	AO	K. Imamiya et al., "MP6.6 A 130mm^2 256 Mb NAND Flash with Shallow Trench Isolation Technology", 1999 IEEE International Solid-State Circuits Conference.
	AP	K. Suh et al., "TA7.5: A 3.3V 32 Mb NAND Flash Memory with Incremental Step Pulse Programming Scheme", 1995 IEEE International Solid-State Circuits Conference, pp. 128-129.
	AQ	K. Imamiya et al., "TA7.6: A 35 ns-Cycle-Time 3.3V-Only 32 Mb NAND Flash EEPROM", 1995 IEEE International Solid-State Circuits Conference, pp. 130-131.

Examiner	Date Considered

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.